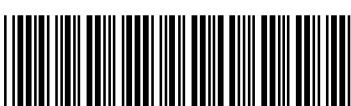


<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10710600	FUJISAKI, IWAO
	<b>Examiner</b>	<b>Art Unit</b>
	DAVID Q NGUYEN	2617

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
455	556.1	04/21/09	DN
370	338	04/21/09	DN
455	456.1	08/12/09	DN
705	26	08/12/09	DN
340	426.1	08/12/09	DN
update search		10/14/2009	DN
update search		04/08/10	DN
455	558	04/08/10	DN
455	567	04/08/10	DN
455	410	04/08/10	DN
Update search		08/10/2010	
Update search		11/30/2010	DN

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Text search	04/21/09	DN
Text search	08/12/09	DN
Text search	10/24/2009	DN
Text search	04/08/10	DN
Text search	08/10/2010	DN
Update search	11/30/2010	DN

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>